Notice of References Cited Application/Control No. 10/659,744 Examiner Dzung D. Tran U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination NABEYAMA ET AL. Art Unit Page 1 of 1

Document Number Country Code-Number-Kind Code Classification Name MM-YYYY * US-6,266,170 07-2001 398/147 Fee, John Arthur Α В US-US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-Μ

FOREIGN PATENT DOCUMENTS

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